

Notice of References Cited	Application/Control No. 10/666,024	Applicant(s)/Patent Under Reexamination HAYHOW, REID	
	Examiner Phung My Chung	Art Unit 2138	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,763,490 B1	07-2004	Krech et al.	714/738
*	B	US-6,687,855 B1	02-2004	Krech et al.	714/30
*	C	US-6,598,112 B1	07-2003	Jordan et al.	711/2
*	D	US-7,028,148 B2	04-2006	Andoh, Junichi	711/154
*	E	US-6,925,584 B2	08-2005	Padwekar et al.	714/30
*	F	US-6,424,926 B1	07-2002	Mak, Tak M.	702/117
*	G	US-6,170,070 B1	01-2001	Ju et al.	714/718
*	H	US-5,953,268 A	09-1999	Kuhara, Shigeru	365/200
*	I	US-2005/0239494 A1	10-2005	Klassen et al.	455/550.1
*	J	US-4,760,377	07-1988	Jackson, Philip C.	341/101
*	K	US-6,574,626 B1	06-2003	Regelman et al.	707/6
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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